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Sheet	ī	of	2	Attorney Docket Number	WESD 2003-001		

U.S. PATENT DOCUMENTS									
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		US.							

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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS							
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where publisher	T ²				
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